

MOSFET – Power, Single, N-Channel, μ8FL 30 V, 52 A NTTFS4C08N

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

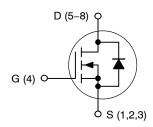
Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	V		
Continuous Drain		T _A = 25°C	Ι _D	15	Α
Current R _{θJA} (Note 1)		T _A = 85°C		10.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.13	W
Continuous Drain		T _A = 25°C	I _D	21	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C	1	15	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.2	W
Continuous Drain	State	T _A = 25°C	I _D	9.3	Α
Current R _{θJA} (Note 2)		T _A = 85°C	1	6.7	1
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.82	W
Continuous Drain		T _C = 25°C	Ι _D	52	Α
Current R _{θJC} (Note 1)		T _C = 85°C		37.5	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	25.5	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I _{DM}	144	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Did	I _S	23	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to–Source Avalanche Energy ($T_J=25^{\circ}C$, $V_{GS}=10$ V, $I_L=29A_{pk}$, $L=0.1$ mH, $R_G=25\Omega$) (Note 3)			E _{AS}	42	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at T_J = 25°C, V_{GS} = 10 V, I_L = 21 A, E_{AS} = 22 mJ.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	5.9 mΩ @ 10 V	52 A
30 V	9.0 mΩ @ 4.5 V	32 A

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB

MARKING DIAGRAM



4C08 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package Shipping	
NTTFS4C08NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	58.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	153	*C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	30	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	$V_{GS} = 0 \text{ V, } I_{D(aval)} = 12.6 \text{ A,}$ $T_{case} = 25^{\circ}\text{C, } t_{transient} = 100 \text{ ns}$		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				13.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0	1
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)					-		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.3		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		4.7	5.9	
		V _{GS} = 4.5 V	I _D = 18 A		7.2	9.0	mΩ
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			42		S
Gate Resistance	R_{G}	T _A = 25°C		0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			1113		pF
Output Capacitance	C _{OSS}				702		
Reverse Transfer Capacitance	C _{RSS}	1			39		1
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 1	5 V, f = 1 MHz		0.035		
Total Gate Charge	Q _{G(TOT)}				8.4	15	
Threshold Gate Charge	Q _{G(TH)}	1			1.8	3.5	1
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			3.5	7.0	nC
Gate-to-Drain Charge	Q_{GD}				3.3	6.0	
Gate Plateau Voltage	V_{GP}				3.4	7.0	V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			18.2	35	nC
SWITCHING CHARACTERISTICS (Note 7)							
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.0		
Rise Time	t _r				33		
Turn-Off Delay Time	t _{d(OFF)}				15		ns
Fall Time	t _f				4.0		

- 6. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
 7. Switching characteristics are independent of operating junction temperatures.

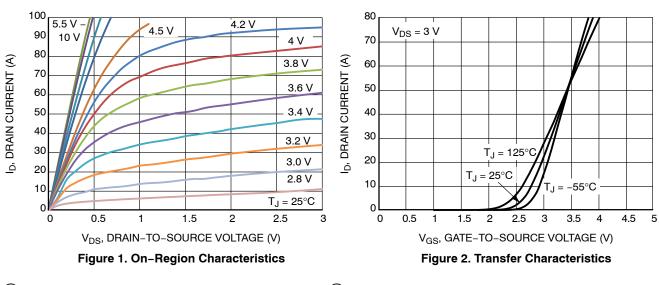
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 7)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			7.0		ns ns
Rise Time	t _r				26		
Turn-Off Delay Time	t _{d(OFF)}				19		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARACTI	ERISTICS				-		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}.$ $T_{J} = 25^{\circ}\text{C}$			0.79	1.1	.,
		$V_{GS} = 0 V,$ $I_{S} = 10 A$	T _J = 125°C		0.66		V
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dIS/dt = 100 A/ μ s, I_{S} = 30 A			28.3		
Charge Time	t _a				14.5		ns
Discharge Time	t _b				13.8		1
Reverse Recovery Charge	Q _{RR}	1		15.3		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{6.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



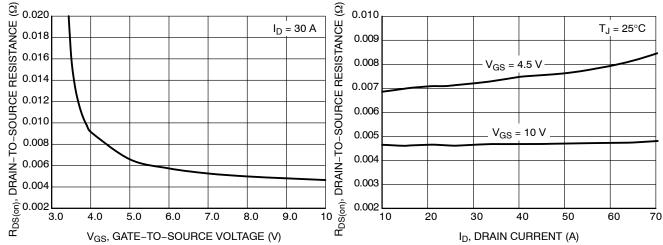


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

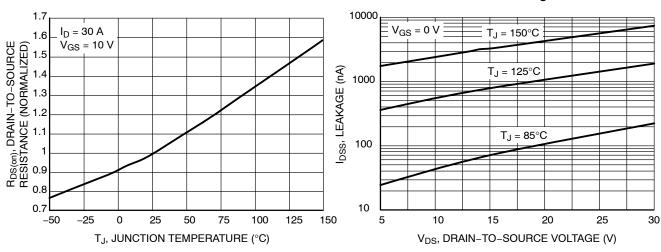


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

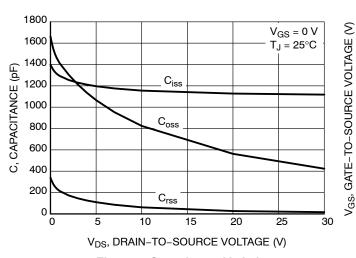


Figure 7. Capacitance Variation

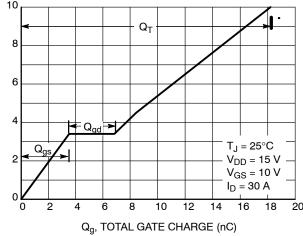


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

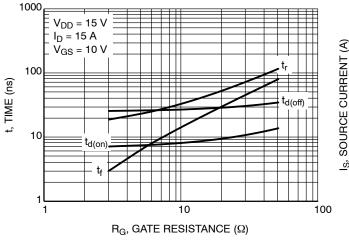


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

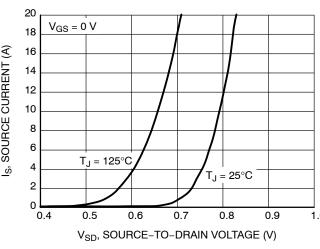


Figure 10. Diode Forward Voltage vs. Current

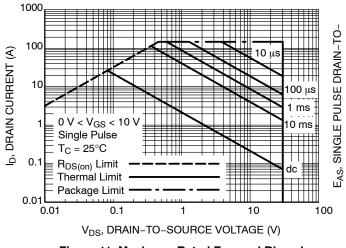


Figure 11. Maximum Rated Forward Biased Safe Operating Area

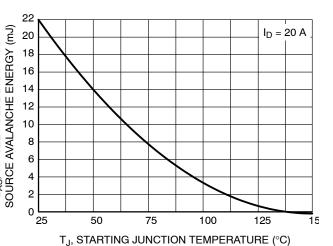


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

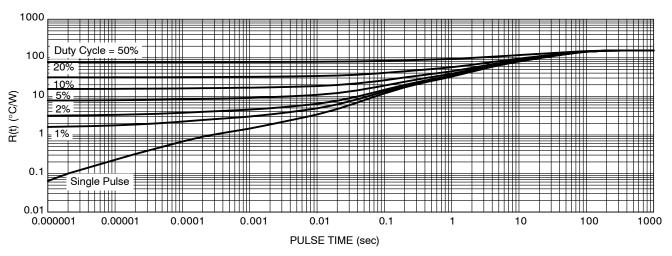


Figure 13. Thermal Response

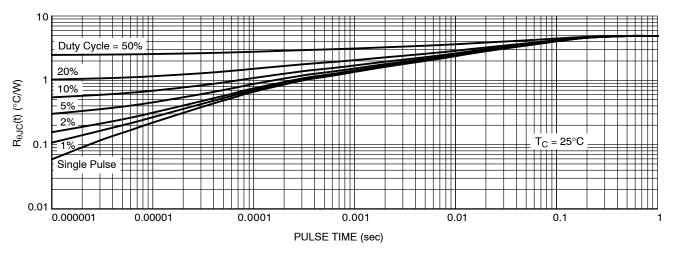


Figure 14. Thermal Response

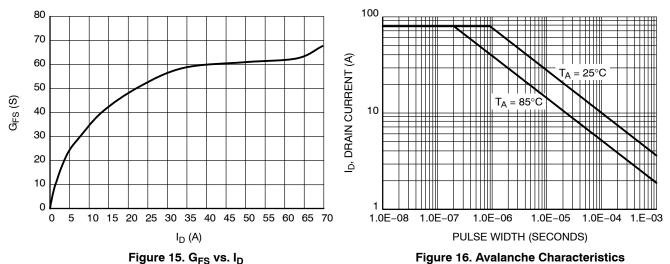


Figure 16. Avalanche Characteristics



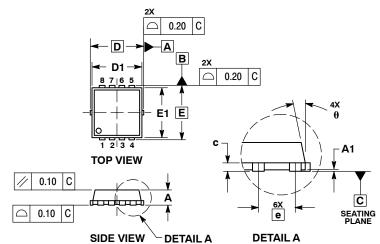




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

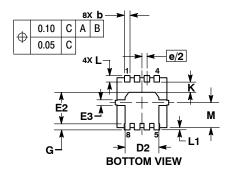
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC			0.026 BS0)	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

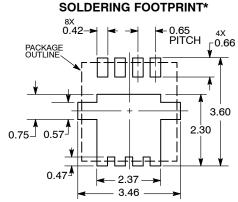


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year = Work Week WW = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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